

### **MOSFET**

### 600V CoolMOS™ SJ S7 Power Device

CoolMOS™ S7T enables the best price performance for low-frequency switching applications. The embedded temperature sensor increases junction temperature sensing accuracy and robustness while keeping an easy and seamless implementation. CoolMOS™ S7T is optimized for "static switching" and high current applications. The new temperature sensor enhances S7 features, allowing the best possible utilization of the power transistor.

### **Features**

- Optimized price performance in low-frequency switching applications
- · High pulse current capability
- Seamless diagnostics at the lowest system cost
- Temperature sense feature for protection and optimized thermal device utilization cost

### **Benefits**

- Reduction of external sensing elements, hence a more compact design compared to electromechanical devices
- Increased system performance
- Minimized conduction losses (eliminate/reduce heat sink)
- Increased system performance
- More compact and more straightforward design
- Lower BOM or/and TCO over a prolonged lifetime
- · More reliability and longer system lifetime

### Potential applications

- Solid state relays and circuit breakers (PLC, Energy storage)
- Line rectification in high power/performance applications (Computing, Telecom, UPS and Solar)

### **Product validation**

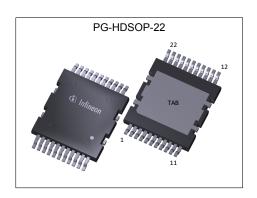
Fully qualified according to JEDEC for Industrial Applications

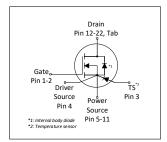
Please note: The source and sense source pins are not exchangeable. Their exchange might lead to malfunction. For paralleling 4pin MOSFET devices the placement of the gate resistor is generally recommended to be on the Driver Source instead of the Gate.



Parameter	Value	Unit
R <sub>DS(on),max</sub>	22	mΩ
$Q_{g,typ}$	150	nC
V <sub>SD</sub>	0.82	V
Pulsed I <sub>SD</sub> , I <sub>DS</sub>	371	Α
ESD class (HBM)	2	JEDEC JS-001

Type / Ordering Code	Package	Marking	Related Links
IPQC60T022S7	PG-HDSOP-22	60I022S7	see Appendix A











# 600V CoolMOS™ SJ S7 Power Device IPQC60T022S7



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## 600V CoolMOS™ SJ S7 Power Device IPQC60T022S7



1 Maximum ratings at  $T_j = 25$ °C, unless otherwise specified

**Maximum MOSFET ratings** Table 2

Devementar	Oh a l	Values			l lmi4		
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Drain current rating <sup>1)</sup>	I <sub>D</sub>	-	-	90 24	А	T <sub>C</sub> =25°C T <sub>C</sub> =140°C	
Pulsed drain current <sup>2)</sup>	I <sub>D,pulse</sub>	-	-	371	Α	T <sub>C</sub> =25°C	
Avalanche energy, single pulse	<b>E</b> AS	-	-	286	mJ	I <sub>D</sub> =3.7A; V <sub>DD</sub> =50V; see table 11	
Avalanche current, single pulse	I <sub>AS</sub>	-	-	3.7	Α	-	
MOSFET dv/dt ruggedness <sup>3)</sup>	dv/dt	-	-	20	V/ns	V <sub>DS</sub> = 0V to 300V	
Gate source voltage (static)	V <sub>GS</sub>	-20	-	20	V	static	
Gate source voltage (dynamic)	V <sub>GS</sub>	-30	-	30	V	AC (f>1 Hz)	
Power dissipation	P <sub>tot</sub>	-	-	416	W	T <sub>C</sub> =25°C	
Storage temperature	T <sub>stg</sub>	-55	-	150	°C	-	
Operating junction temperature <sup>1)</sup>	T <sub>j</sub>	-55	-	150	°C	-	
Extended operating junction temperature	T <sub>j</sub>	150	-	175	°C	≤50 h in the application lifetime	
Mounting torque	-	-	-	n.a.	Ncm	-	
Diode forward current rating	Is	-	-	24	A	T <sub>C</sub> =140°C Current is limited by T <sub>j max</sub> = 150°C; Lower case temp does increase current capability	
Diode pulse current <sup>1)</sup>	I <sub>S,pulse</sub>	-	-	371	Α	T <sub>C</sub> =25°C	
Reverse diode dv/dt <sup>4)</sup>	dv/dt	-	-	5	V/ns	$V_{\rm DS}$ =0 to 300V, $I_{\rm SD}$ <=23A, $T_{\rm j}$ =25°C see table 9	
Maximum diode commutation speed	di <sub>f</sub> /dt	-	-	800	A/μs	$V_{\rm DS}$ =0 to 300V, $I_{\rm SD}$ <=23A, $T_{\rm j}$ =25°0 see table 9	
Insulation withstand voltage	V <sub>ISO</sub>	-	-	n.a.	V	-	

 $<sup>^{1)}</sup>$  Please consider the App Note: 600 V CoolMOSTM S7 with Temperature Sense for high delta  $T_J$  usage  $^{2)}$  Pulse width  $t_p$  limited by  $T_{j,\text{max}}$   $^{3)}$  The dv/dt has to be limited by appropriate gate resistor  $^{4)}$  Identical low side and high side switch

# 600V CoolMOS™ SJ S7 Power Device

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## 2 Thermal characteristics

### Table 3 Thermal characteristics

Davamatav	Complete		Values		11:4	Note / Took Condition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Thermal resistance, junction - case	R <sub>thJC</sub>	-	-	0.3	°C/W	-
Thermal resistance, junction - ambient	R <sub>thJA</sub>	-	-	62	°C/W	device on PCB, minimal footprint
Thermal resistance, junction - ambient for SMD version	<b>/ NthJA</b>	-	45	55	°C/W	Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70µm thickness) copper area. Tap exposed to air. PCB is vertical without air stream cooling.
Soldering temperature, reflow soldering allowed	T <sub>sold</sub>	-	-	260	°C	reflow MSL1

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### 3 Electrical characteristics

at T<sub>j</sub>=25°C, unless otherwise specified

### Table 4 Static characteristics

For applications with applied blocking voltage >420V, it is required that the customer evaluates the impact of cosmic radiation effect in early design phase and contacts the Infineon sales office for the necessary technical support by Infineon

	Oh. a.l		Values			Note / Took Open William
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	600	-	-	V	$V_{GS}$ =0V, $I_D$ =1mA
Gate threshold voltage	$V_{(GS)th}$	3.5	4.0	4.5	V	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 1.43 \rm mA$
Zero gate voltage drain current	$I_{ m DSS}$	-	- 50	5	μΑ	V <sub>DS</sub> =600V, V <sub>GS</sub> =0V, T <sub>j</sub> =25°C V <sub>DS</sub> =600V, V <sub>GS</sub> =0V, T <sub>j</sub> =150°C
Gate-source leakage current	I <sub>GSS</sub>	-	-	100	nA	V <sub>GS</sub> =20V, V <sub>DS</sub> =0V
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	0.02 0.046	0.022	Ω	V <sub>GS</sub> =12V, I <sub>D</sub> =23A, T <sub>j</sub> =25°C V <sub>GS</sub> =12V, I <sub>D</sub> =23A, T <sub>j</sub> =150°C
Gate resistance	R <sub>G</sub>	-	0.8	-	Ω	f=1MHz, open drain

**Table 5** Dynamic characteristics

Parameter	0	Values				Nata (Table Constitution
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance	Ciss	-	5640	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =300V, f=250kHz
Output capacitance	Coss	-	89	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =300V, f=250kHz
Effective output capacitance, energy related <sup>1)</sup>	C <sub>o(er)</sub>	-	302	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =0 to 300V
Effective output capacitance, time related <sup>2)</sup>	C <sub>o(tr)</sub>	-	2677	-	pF	$I_D$ =constant, $V_{GS}$ =0V, $V_{DS}$ =0 to 300V
Output charge	Qoss	-	803	-	nC	V <sub>GS</sub> =0V, V <sub>DS</sub> =0 to 300V
Turn-on delay time	t <sub>d(on)</sub>	-	30	-	ns	$V_{\rm DD}$ =300V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =23A, $R_{\rm G}$ =5.3 $\Omega$ ; see table 9
Rise time	t <sub>r</sub>	-	6	-	ns	$V_{\rm DD}$ =300V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =23A, $R_{\rm G}$ =5.3 $\Omega$ ; see table 9
Turn-off delay time	$t_{ m d(off)}$	-	142	-	ns	$V_{\rm DD}$ =300V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =23A, $R_{\rm G}$ =5.3 $\Omega$ ; see table 9
Fall time	t <sub>f</sub>	-	10	-	ns	$V_{\rm DD}$ =300V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =23A, $R_{\rm G}$ =5.3 $\Omega$ ; see table 9

 Table 6
 Gate charge characteristics

Parameter	Cymbal		Values		Unit	Note / Test Condition
	Symbol	Min.	Тур.	Max.		
Gate to source charge	Q <sub>gs</sub>	-	31	-	nC	$V_{DD}$ =300V, $I_{D}$ =23A, $V_{GS}$ =0 to 12V
Gate to drain charge	$Q_{gd}$	-	49	-	nC	$V_{DD}$ =300V, $I_{D}$ =23A, $V_{GS}$ =0 to 12V
Gate charge total	$Q_g$	-	150	-	nC	$V_{DD}$ =300V, $I_{D}$ =23A, $V_{GS}$ =0 to 12V
Gate plateau voltage	V <sub>plateau</sub>	-	5.4	-	V	$V_{DD}$ =300V, $I_{D}$ =23A, $V_{GS}$ =0 to 12V

 $<sup>^{1)}</sup>$   $C_{\text{o(er)}}$  is a fixed capacitance that gives the same stored energy as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 300V  $^{2)}$   $C_{\text{o(tr)}}$  is a fixed capacitance that gives the same charging time as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 300V

# **600V CoolMOS™ SJ S7 Power Device**

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## Table 7 Reverse diode characteristics

Parameter	Cymphal	Values			11	Nata / Tank Candition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Diode forward voltage	<b>V</b> <sub>SD</sub>	-	0.82	-	V	V <sub>GS</sub> =0V, I <sub>F</sub> =23A, T <sub>j</sub> =25°C
Reverse recovery time	t <sub>rr</sub>	-	410	-	ns	$V_R$ =300V, $I_F$ =23A, $di_F/dt$ =100A/ $\mu$ s; see table 8
Reverse recovery charge	Q <sub>rr</sub>	-	10	-	μC	$V_R$ =300V, $I_F$ =23A, $di_F/dt$ =100A/ $\mu$ s; see table 8
Peak reverse recovery current	I <sub>rrm</sub>	-	48	-	А	$V_R$ =300V, $I_F$ =23A, $di_F/dt$ =100A/ $\mu$ s; see table 8

## 600V CoolMOS™ SJ S7 Power Device IPQC60T022S7



# **4 Temperature Sensor parameters** at $T_j$ =25°C, unless otherwise specified

Table 8 **Maximum ratings** 

Parameter	Cumbal		Value	s	11	Note / Took Operatition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Repetitive Peak Reverse Voltage	$V_{RRM}$	-	-	15	V	<i>I</i> <sub>R</sub> = 100 μA
Sensor forward current	I <sub>F</sub>	-	-	5	mA	-
Repetitive peak forward current	I <sub>F_pulse</sub>	-	-	25	mA	t <sub>pulse</sub> = 1 ms, T <sub>period</sub> = 10 ms
Non-repetitive peak forward current	I <sub>FSM</sub>	- - -	- - -	1.5 0.2 0.1	A	$T_C$ = 25°C, $t_{pulse}$ = 1 $\mu s$ $T_C$ = 25°C, $t_{pulse}$ = 1 ms $T_C$ = 25°C, $t_{pulse}$ = 1 s
Junction Temperature	T <sub>j</sub>	-	-	185	°C	t < 50h, Sensor only

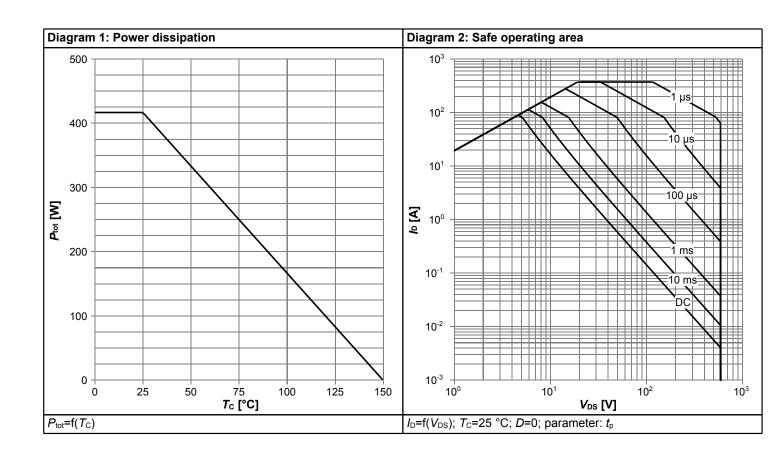
#### **Electrical characteristics** Table 9

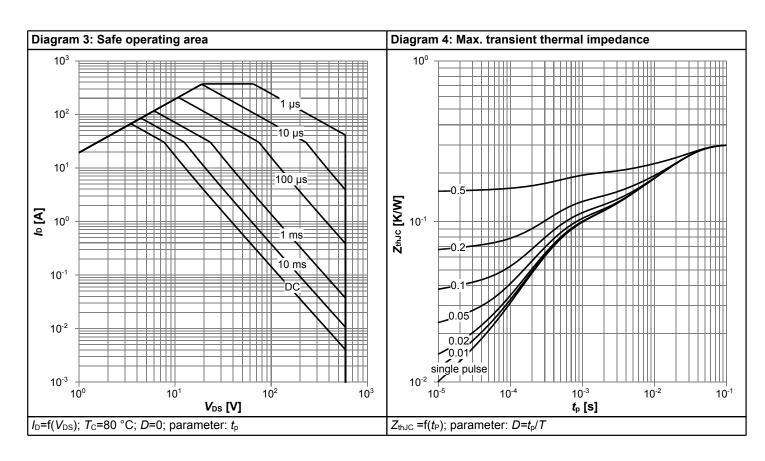
Parameter	Symbol	Values			Unit	Note / Test Condition	
raiailletei	Symbol	Min.	Тур.	Max.	Ullit	Note / Test Condition	
Sensor forward voltage <sup>1)</sup>	V <sub>F_25</sub>	1.5601 - - 2.0665	1.6019 1.8103 1.9806 2.0966	-	V	$T_{j} = 25^{\circ}\text{C}, \ I_{F} = 10 \ \mu\text{A}$ $T_{j} = 25^{\circ}\text{C}, \ I_{F} = 50 \ \mu\text{A}$ $T_{j} = 25^{\circ}\text{C}, \ I_{F} = 200 \ \mu\text{A}$ $T_{j} = 25^{\circ}\text{C}, \ I_{F} = 500 \ \mu\text{A}$	
Sensor forward voltage temperature coefficient	TC	- - -	5.9644 5.5880 5.2287 5.0135	-	mV/K	$\begin{array}{l} 25^{\circ}C \leq T_{j} \leq 175^{\circ}C, \ I_{F} = 10 \ \mu A \\ 25^{\circ}C \leq T_{j} \leq 175^{\circ}C, \ I_{F} = 50 \ \mu A \\ 25^{\circ}C \leq T_{j} \leq 175^{\circ}C, \ I_{F} = 200 \ \mu A \\ 25^{\circ}C \leq T_{j} \leq 175^{\circ}C, \ I_{F} = 500 \ \mu A \end{array}$	
Sensor forward voltage	V <sub>F_175</sub>	-	0.7072 0.9721 1.1963 1.3445	-	V	$T_{j} = 175^{\circ}\text{C}, \ I_{F} = 10 \ \mu\text{A}$ $T_{j} = 175^{\circ}\text{C}, \ I_{F} = 50 \ \mu\text{A}$ $T_{j} = 175^{\circ}\text{C}, \ I_{F} = 200 \ \mu\text{A}$ $T_{j} = 175^{\circ}\text{C}, \ I_{F} = 500 \ \mu\text{A}$	
Reverse leakage current	I <sub>R</sub>	-	-	1 20	μA	V <sub>R</sub> = 10V, T <sub>j</sub> = 25°C V <sub>R</sub> = 10V, T <sub>j</sub> = 175°C	
Sensor G Capacitance	C <sub>GTS</sub>	-	4.2	-	pF	f = 1 MHz, I <sub>F</sub> = 50 μA	
Sensor Capacitance	C <sub>STS</sub>	-	4.8	-	pF	f = 1 MHz, I <sub>F</sub> = 50 μA	
Anode-Drain Capacitance	C <sub>DTS</sub>	-	0.5	-	pF	f = 1 MHz, V <sub>DS</sub> = 0 V	

7 Final Data Sheet Rev. 2.0, 2023-12-11

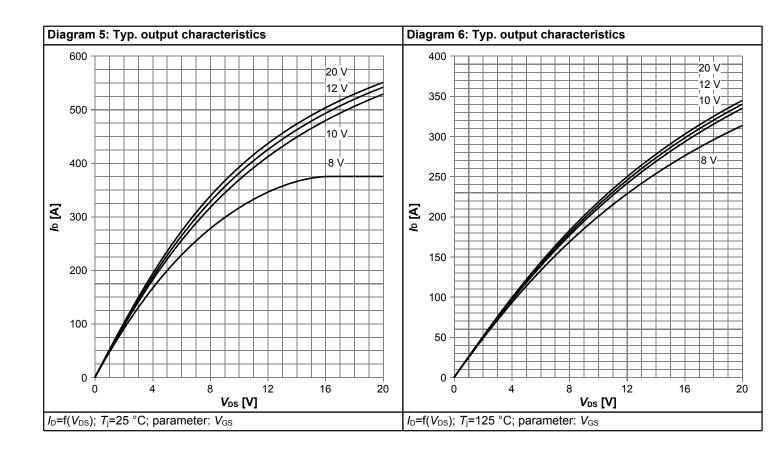


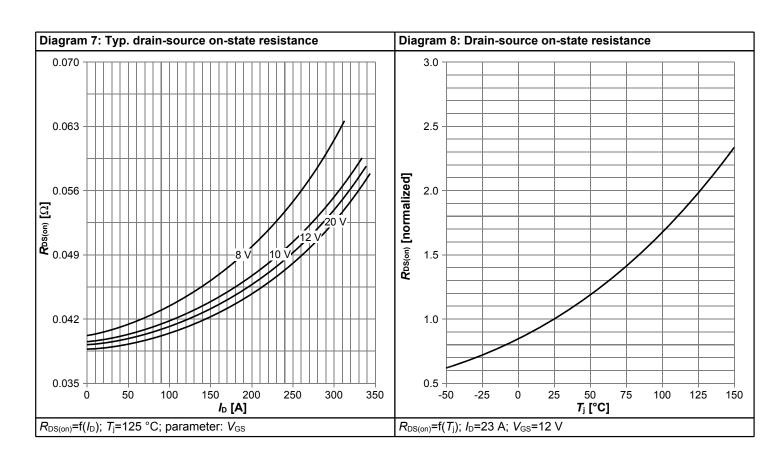
## 5 Electrical characteristics diagrams



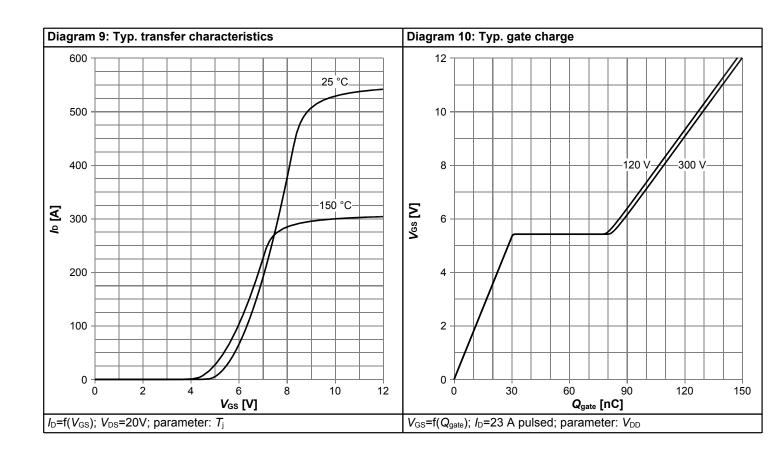


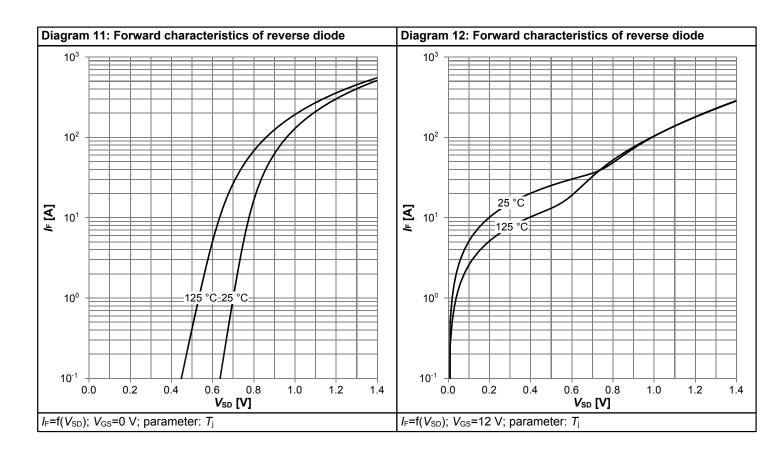




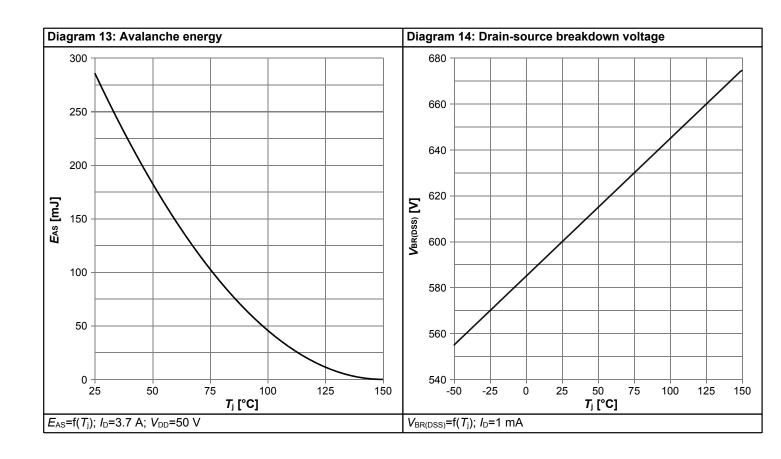


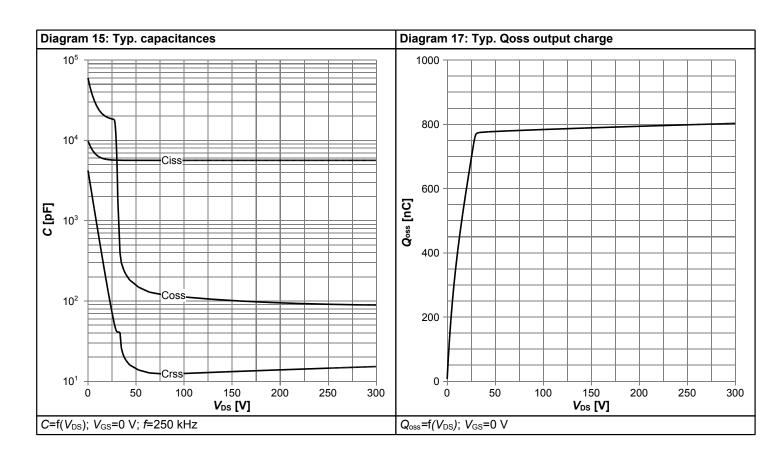




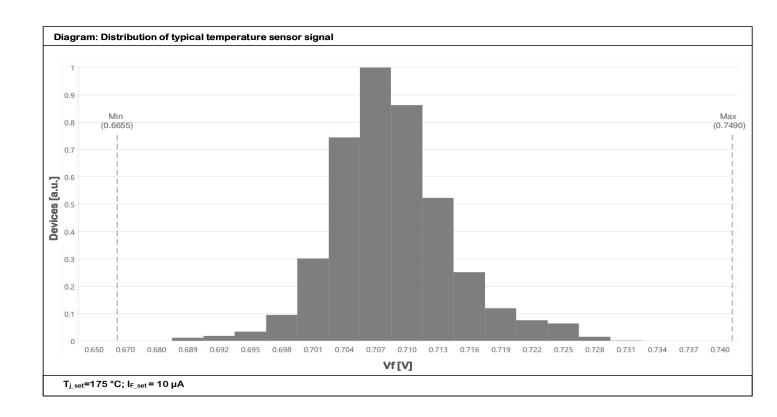














### 6 Test Circuits

Table 10 Diode characteristics

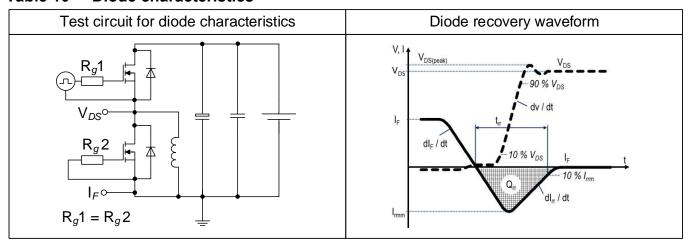


Table 11 Switching times (ss)

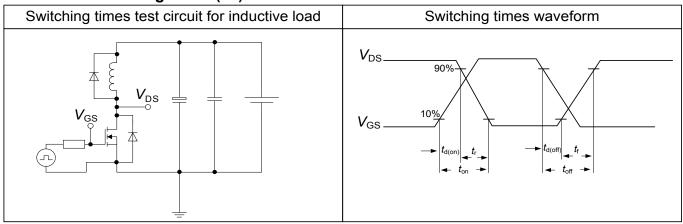
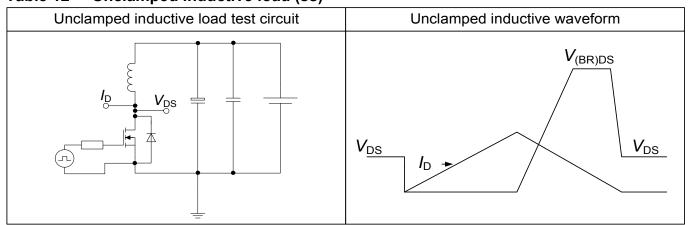


Table 12 Unclamped inductive load (ss)





# 7 Package Outlines

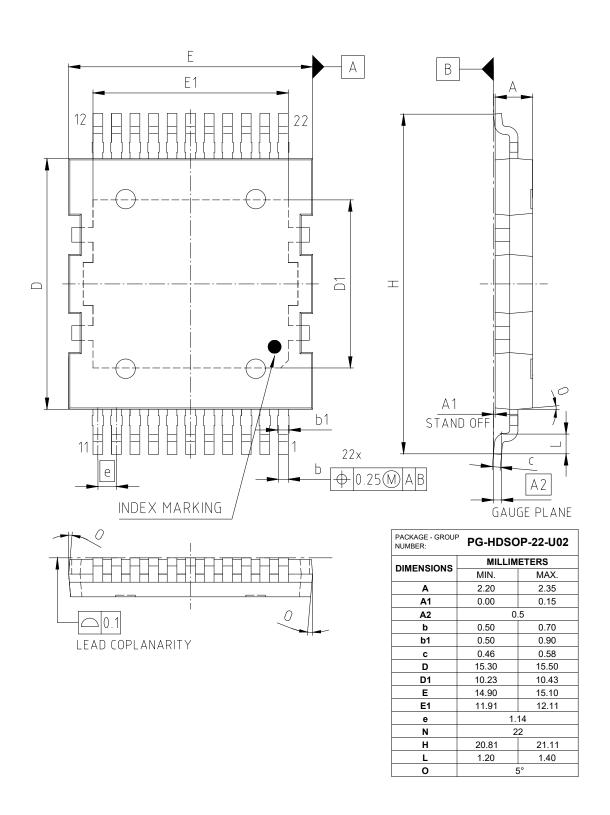


Figure 1 Outline PG-HDSOP-22, dimensions in mm

# 600V CoolMOS™ SJ S7 Power Device IPQC60T022S7



# 8 Appendix A

### Table 13 Related Links

• IFX CoolMOS S7T Webpage: www.infineon.com

• IFX CoolMOS S7T application note: <a href="https://www.infineon.com">www.infineon.com</a>

• IFX CoolMOS S7T simulation model: www.infineon.com

• IFX Design tools: www.infineon.com

# 600V CoolMOS™ SJ S7 Power Device





### **Revision History**

IPQC60T022S7

Revision: 2023-12-11, Rev. 2.0

Previous Revision

Revision	Date	Subjects (major changes since last revision)					
2.0	2023-12-11	Release of final version					

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